

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/820,362	MIYAJIMA, KEIKO
	<b>Examiner</b>	<b>Art Unit</b>
	BRIAN P. YENKE	2622

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner